Notice of References Cited

Application/Control No. 10/644,897	Applicant(s)/Patent Under Reexamination OZAWA ET AL.	
Examiner	Art Unit	
Martin J. Angebranndt	1756	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2003/0161257	08-2003	Yusu et al.	369/285
*	В	US-6,246,656	06-2001	Kawakubo et al.	369/112.23
*	С	US-2003/0183511	10-2003	Kakuta et al.	204/192.27
*	D	US-6,590,857	07-2003	Ohkubo et al.	369/275.4
*	E	US-4,731,620	03-1988	Yabe et al.	346/137
*	F	US-2002/0025443	02-2002	Ohno, Takashi	428/469
*	G	US-2001/0044000	11-2001	Miki, Takeshi	428/64.2
*	Н	US-2001/0036596	11-2001	Mizushima et al.	430/270.13
*	ı	US-6,924,018	08-2005	Ozawa et al.	428/64.1
	J	US-			
	к	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	2003-187498	07-2003	Japan	Ishida et al.	***
	0	2000-099995	04-2000	Japan	Usami et al.	***
	Р	2000-195103	07-2000	Japan	Yashiro et al.	***
	Q	1139340	10-2001	EP	Fukuzawa	***
	R	2001-110104	04-2001	Japan	Aspen et al.	***
	s	04-251453	09-1992	Japan	***	***
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	υ	
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	w	
	х	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.